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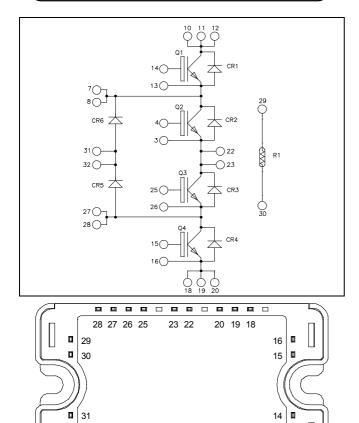
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Three level inverter Trench + Field Stop IGBT Power Module



All multiple inputs and outputs must be shorted together Example: 10/11/12 ; 7/8 ...

7 8

Q1 to Q4 Absolute maximum ratings

1 32

2 3 4

Π

APTGT50TL60T3G

$V_{CES} = 600V$ $I_C = 50A$ @ Tc = 80°C

Application

- Solar converter
- Uninterruptible Power Supplies

Features

- Trench + Field Stop IGBT Technology
 - Low voltage drop
 - Low tail current
 - Switching frequency up to 20 kHz
 - Soft recovery parallel diodes
 - Low diode VF
 - Low leakage current
 - RBSOA and SCSOA rated
- Kelvin emitter for easy drive
- Very low stray inductance
- High level of integration
- Internal thermistor for temperature monitoring

Benefits

- Stable temperature behavior
- Very rugged
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Easy paralleling due to positive TC of VCEsat
- Low profile
- RoHS Compliant

Symbol	Parameter		Max ratings	Unit
V _{CES}	Collector - Emitter Breakdown Voltage		600	V
т	Continuous Collector Current	$T_C = 25^{\circ}C$	80	
I _C	T	$T_C = 80^{\circ}C$	50	А
I _{CM}	Pulsed Collector Current	$T_C = 25^{\circ}C$	100	
V _{GE}	Gate – Emitter Voltage		±20	V
P _D	Maximum Power Dissipation	$T_C = 25^{\circ}C$	176	W
RBSOA	Reverse Bias Safe Operating Area	$T_{\rm J} = 150^{\circ}{\rm C}$	100A @ 550V	

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10 11 12

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com



All ratings (a) $T_j = 25^{\circ}C$ unless otherwise specified

Q1 to Q4 Electrical Characteristics

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit	
I _{CES}	Zero Gate Voltage Collector Current	$V_{GE} = 0V, V_{CE} =$			250	μA	
V	Collector Emitter Saturation Voltage	$V_{GE} = 15V$	$T_j = 25^{\circ}C$		1.5	1.9	V
V _{CE(sat)}		$I_C = 50A$	$T_{j} = 150^{\circ}C$		1.7		v
V _{GE(th)}	Gate Threshold Voltage	$V_{GE} = V_{CE}, I_C = 600 \mu A$		5.0	5.8	6.5	V
I _{GES}	Gate – Emitter Leakage Current	$V_{GE} = 20V, V_{CE}$	= 0V			600	nA

Q1 to Q4 Dynamic Characteristics

-	Characteristic	Test Conditions	Min	Тур	Max	Unit
Cies	Input Capacitance	$V_{GE} = 0V$		3150		
C _{oes}	Output Capacitance	$V_{CE} = 25V$		200		pF
C _{res}	Reverse Transfer Capacitance	f = 1 MHz		95		
Q _G	Gate charge	V_{GE} =±15V, I _C =50A V _{CE} =300V		0.5		μC
T _{d(on)}	Turn-on Delay Time	Inductive Switching (25°C)		110		
T _r	Rise Time	$V_{GE} = \pm 15V$		45		
T _{d(off)}	Turn-off Delay Time	$V_{Bus} = 300V$ $I_{C} = 50A$		200		ns
T _f	Fall Time	$R_G = 8.2\Omega$		40		
T _{d(on)}	Turn-on Delay Time	Inductive Switching (150°C)	120		
Tr	Rise Time	$V_{GE} = \pm 15V$		50		
T _{d(off)}	Turn-off Delay Time	$V_{Bus} = 300V$ $I_{C} = 50A$		250		ns
T _f	Fall Time	$R_G = 8.2\Omega$		60		
Eon	Turn-on Switching Energy	$V_{GE} = \pm 15V$ $T_j = 25^{\circ}C$		0.3		mJ
Lon	Turn-on Switching Energy	$V_{Bus} = 300V$ $T_j = 150^{\circ}C$	C	0.43		IIIJ
E _{off}	Turn-off Switching Energy	$I_C = 50A$ $T_j = 25^{\circ}C$		1.35		mJ
011		$R_G = 8.2\Omega$ $T_j = 150^{\circ}C$	C	1.75		
I _{sc}	Short Circuit data	$V_{GE} \le 15V$; $V_{Bus} = 360V$ $t_p \le 6\mu s$; $T_i = 150^{\circ}C$		250		А
R _{thJC}	Junction to Case Thermal Resistance				0.85	°C/W



CR1 to CR4 diode ratings and characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
V _{RRM}	Maximum Peak Repetitive Reverse Voltage			600			V
I _{RM}	Maximum Reverse Leakage Current	V _R =600V	$T_i = 25^{\circ}C$ $T_i = 150^{\circ}C$			150 350	μΑ
I _F	DC Forward Current		$Tc = 80^{\circ}C$		30		Α
V	Diode Forward Voltage	$I_F = 30A$	$T_i = 25^{\circ}C$		1.6	2	V
$V_{\rm F}$		$V_{GE} = 0V$	$T_{i} = 150^{\circ}C$		1.5		v
t _{rr}	Reverse Recovery Time	$T_i = 150^{\circ}$	$T_j = 25^{\circ}C$		100		ns
ι _{rr}			$T_{j} = 150^{\circ}C$		150		115
Q _{rr}	Reverse Recovery Charge	$I_F = 30A$ $V_R = 300V$	$T_j = 25^{\circ}C$		1.5		μC
Qrr	Reverse Recovery Charge	$di/dt = 1800 \text{ A}/\mu\text{s}$	$T_{i} = 150^{\circ}C$		3.1		μυ
Б	Pavara Pasavary Epargy		$T_j = 25^{\circ}C$		0.34		mJ
E _{rr}	Reverse Recovery Energy		$T_{j} = 150^{\circ}C$		0.75		111J
R _{thJC}	Junction to Case Thermal Resistance					2.45	°C/W

CR5 & CR6 diode ratings and characteristics

Symbol	Characteristic	Test Conditions	Test Conditions		Тур	Max	Unit
V _{RRM}	Maximum Peak Repetitive Reverse Voltage			600			V
I _{RM}	Maximum Reverse Leakage Current	V _R =600V	$T_j = 25^{\circ}C$ $T_j = 150^{\circ}C$			150 350	μA
I _F	DC Forward current		$T_j = 130 \text{ C}$ $Tc = 80^{\circ}\text{C}$		50	330	А
$V_{\rm F}$	Diode Forward Voltage	$I_{\rm F} = 50 A$ $V_{\rm GE} = 0 V$	$T_{j} = 25^{\circ}C$ $T_{i} = 150^{\circ}C$		1.6 1.5	2	V
t _{rr}	Reverse Recovery Time	$I_F = 50A$ $V_R = 300V$ $di/dt = 1800A/\mu s$	$T_j = 25^{\circ}C$ $T_j = 150^{\circ}C$		100 150		ns
Q _{rr}	Reverse Recovery Charge		$T_j = 25^{\circ}C$ $T_i = 150^{\circ}C$		2.6 5.4		μC
E _{rr}	Reverse Recovery Energy		$T_{i} = 25^{\circ}C$ $T_{i} = 150^{\circ}C$		0.60		mJ
R _{thJC}	Junction to Case Thermal Resistance		• *			1.42	°C/W

Temperature sensor NTC (see application note APT0406 on www.microsemi.com for more information). Symbol Characteristic Min Type

Symbol	Characteristic	Min	Тур	Max	Unit
R ₂₅	Resistance @ 25°C		50		kΩ
$\Delta R_{25}/R_{25}$			5		%
B _{25/85}	$T_{25} = 298.15 \text{ K}$		3952		K
$\Delta B/B$	T _C =100°C		4		%

$$R_{T} = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$

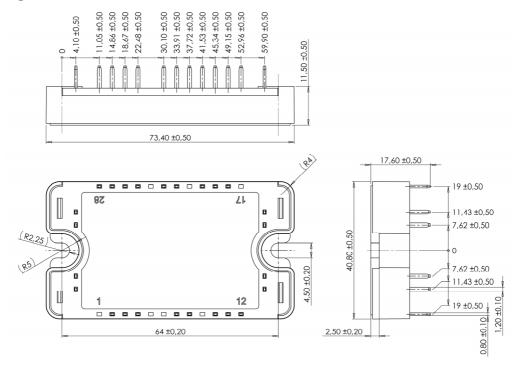
T: Thermistor temperature R_T : Thermistor value at T



Thermal and package characteristics

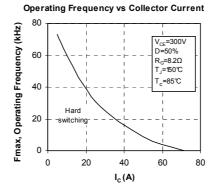
Symbol	Characteristic			Min	Тур	Max	Unit
V _{ISOL}	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4000			V
TJ	Operating junction temperature range			-40		175	
T _{STG}	Storage Temperature Range			-40		125	°C
T _C	Operating Case Temperature			-40		100	
Torque	Mounting torque	To heatsink	M4	2		3	N.m
Wt	Package Weight					110	g

SP3 Package outline (dimensions in mm)



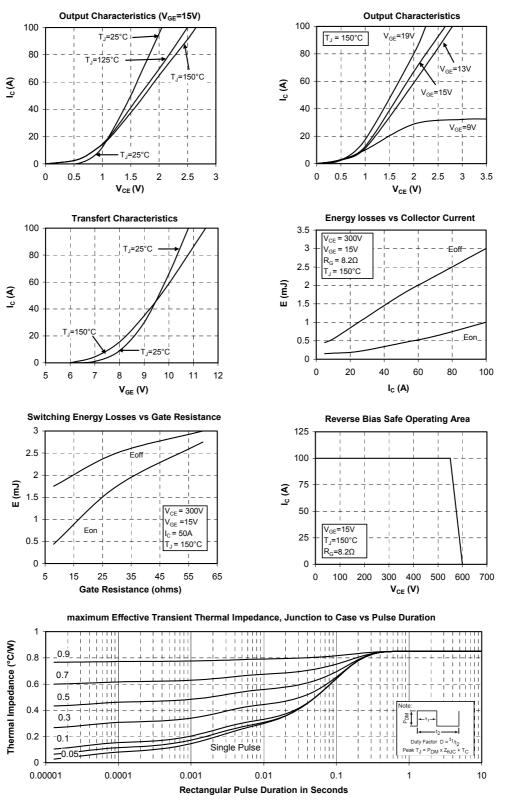
See application note 1901 - Mounting Instructions for SP3 Power Modules on www.microsemi.com

Q1 to Q4 Typical performance curve



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CR1 to CR4 Typical performance curve

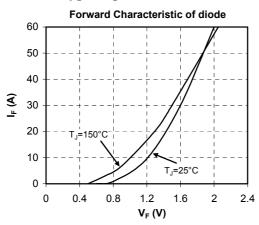
0.5

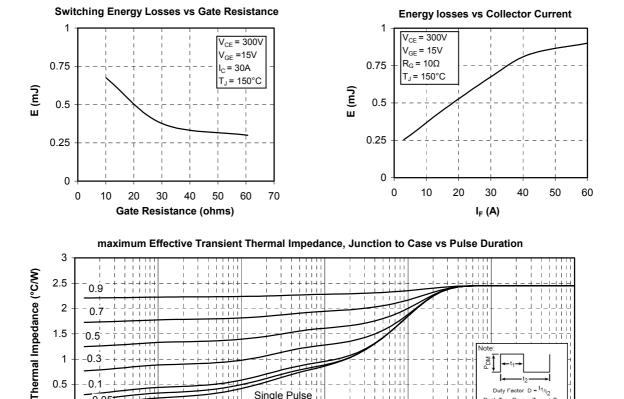
0 0.00001

0.1

-0.05

0.0001





Single Pulse

0.01

Rectangular Pulse Duration in Seconds

0.1

0.001

www.microsemi.com

Duty Factor D = t

Peak T_J = P_{DM} x Z_{0JC}

10

1



PDM

1

Duty Factor D = t_1

10

Peak T_J = P_{DM} x Z_{0JC}

CR5 & CR6 Typical performance curve

0.8

0.6

0.4

0.2

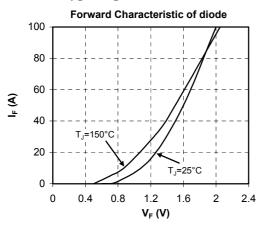
0 0.00001

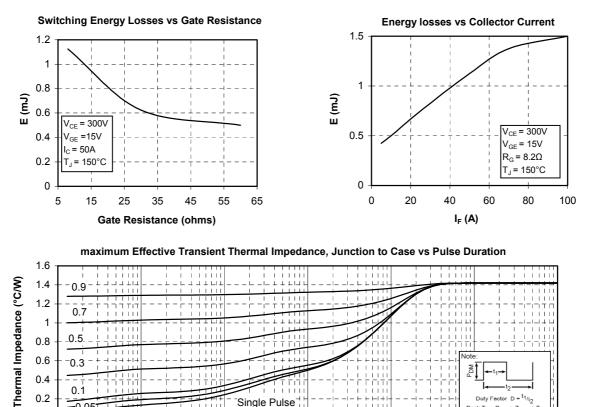
0.3

0.1

0.05

0.0001





± |_

1.1

0.01

Rectangular Pulse Duration in Seconds

0.1

Single Pulse

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. . . .

0.001

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